

# N-Channel 30 V (D-S) MOSFET

PRODUCT SUMMARY					
V <sub>DS</sub> (V)	R <sub>DS(on)</sub> (mΩ)(Typ.)	I <sub>D</sub> (A) <sup>a, e</sup>	Q <sub>g</sub> (Typ.)		
30	1.4 at V <sub>GS</sub> = 10 V		137 nC		
30	2.0 at V <sub>GS</sub> = 4.5 V	133	137 110		

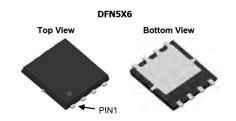
#### **FEATURES**

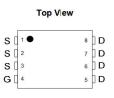
- DT-Trench Power MOSFET
- 100 % R<sub>q</sub> and UIS Tested

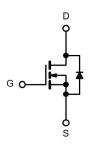
## **APPLICATIONS**

- OR-ing
- Server









N-Channel MOSFET

<b>ABSOLUTE MAXIMUM RATINGS</b>	(T <sub>A</sub> = 25 °C, unle	ess otherwise	noted)	
Parameter	Symbol	Limit	Unit	
Drain-Source Voltage	V <sub>DS</sub>	30	V	
Gate-Source Voltage	V <sub>GS</sub>	± 20		
	T <sub>C</sub> = 25 °C		135 <sup>a, e</sup>	
Continuous Drain Current (T <sub>.I</sub> = 175 °C)	T <sub>C</sub> = 70 °C	1 .	110 <sup>e</sup>	
Continuous Diam Current (1, = 175 C)	T <sub>A</sub> = 25 °C	. I <sub>D</sub>	38 <sup>b, c</sup>	A
	T <sub>A</sub> = 70 °C		32 <sup>b, c</sup>	
Pulsed Drain Current		I <sub>DM</sub>	390	
Avalanche Current Pulse	L = 0.1 mH	I <sub>AS</sub>	36	
Single Pulse Avalanche Energy		E <sub>AS</sub>	650	mJ
Continuous Source-Drain Diode Current	T <sub>C</sub> = 25 °C	I <sub>S</sub>	135 <sup>a, e</sup>	A
Continuous Source-Diam blode Current	T <sub>A</sub> = 25 °C	'S	9.3 <sup>b, c</sup>	
	T <sub>C</sub> = 25 °C		312 <sup>a</sup>	
Maximum Power Dissipation	T <sub>C</sub> = 70 °C	P <sub>D</sub>	218	W
Maximum Fower Dissipation	T <sub>A</sub> = 25 °C	, 0	4.25 <sup>b, c</sup>	
	T <sub>A</sub> = 70 °C		2.97 <sup>b, c</sup>	
Operating Junction and Storage Temperature Ran	T <sub>J</sub> , T <sub>stg</sub>	- 55 to 175	°C	

THERMAL RESISTANCE RATINGS						
Parameter		Symbol	Typical	Maximum	Unit	
Maximum Junction-to-Ambient <sup>b, d</sup>	t ≤ 10 s	R <sub>thJA</sub>	30	35	°C/W	
Maximum Junction-to-Case	Steady State	R <sub>thJC</sub>	0.4	0.48		

- Notes:
  a. Based on T<sub>C</sub> = 25 °C.
  b. Surface mounted on 1" x 1" FR4 board.
  c. t = 10 s.
  d. Maximum under steady state conditions is 90 °C/W.
- e. Calculated based on maximum junction temperature.

Rev. N 1



Parameter	Symbol	Test Conditions	Min .	Тур.	Max.	Unit	
Static							
Drain-Source Breakdown Voltage	V <sub>DS</sub>	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$	30			V	
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$	T <sub>J</sub> I <sub>D</sub> = 250 µA		35		m\//°C	
V <sub>GS(th)</sub> Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	Ι <sub>D</sub> = 250 μΑ		- 7.3		mV/°C	
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS} = V_{GS}, I_D = 250 \mu A$	1		3	V	
Gate-Source Leakage	I <sub>GSS</sub>	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$			± 100	nA	
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	$V_{DS} = 30 \text{ V}, V_{GS} = 0 \text{ V}$			1		
		$V_{DS} = 30 \text{ V}, V_{GS} = 0 \text{ V}, T_{J} = 55 ^{\circ}\text{C}$			10	μA	
On-State Drain Current <sup>a</sup>	I <sub>D(on)</sub>	$V_{DS} \ge 5 \text{ V}, V_{GS} = 10 \text{ V}$	135			Α	
Drain-Source On-State Resistance <sup>a</sup>	_	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 40 A		1.4	1.8	mΩ	
	R <sub>DS(on)</sub>	$V_{GS} = 4.5 \text{ V}, I_D = 40 \text{ A}$		2.0	2.5		
Forward Transconductance <sup>a</sup>	9 <sub>fs</sub>	V <sub>DS</sub> = 15 V, I <sub>D</sub> = 40 A		160		S	
Dynamic <sup>b</sup>							
Input Capacitance	C <sub>iss</sub>			5900		pF	
Output Capacitance	C <sub>oss</sub>	$V_{DS} = 15 \text{ V}$ , $V_{GS} = 0 \text{ V}$ , $f = 1 \text{ MHz}$		700			
Reverse Transfer Capacitance	C <sub>rss</sub>			738			
Total Gate Charge	Qg			137			
Gate-Source Charge	Q <sub>gs</sub>	$V_{DS} = 15 \text{ V}, V_{GS} = 10 \text{ V}, I_{D} = 40 \text{ A}$		12		nC	
Gate-Drain Charge	Q <sub>gd</sub>			28			
Gate Resistance	R <sub>g</sub>	f = 1 MHz		1.5		Ω	
Turn-On Delay Time	t <sub>d(on)</sub>			19			
Rise Time	t <sub>r</sub>	$V_{DD}$ = 15 V, $R_{L}$ = 0.555 $\Omega$		10			
Turn-Off Delay Time	t <sub>d(off)</sub>	$I_D \cong 40$ A, $V_{GEN}$ = 10 V, $R_g$ = 1 $\Omega$		70			
Fall Time	t <sub>f</sub>			10			
Turn-On Delay Time	t <sub>d(on)</sub>			55		ns	
Rise Time	t <sub>r</sub>	$V_{DD}$ = 15 V, $R_{L}$ = 0.625 $\Omega$		180		-	
Turn-Off Delay Time	t <sub>d(off)</sub>	$I_D \cong 40A$ , $V_{GEN} = 4.5$ V, $R_g = 1$ $\Omega$		55			
Fall Time	t <sub>f</sub>			12			
<b>Drain-Source Body Diode Characteristic</b>	:s						
Continuous Source-Drain Diode Current	I <sub>S</sub>	T <sub>C</sub> = 25 °C			135	_	
Pulse Diode Forward Current <sup>a</sup>	I <sub>SM</sub>				390	A	
Body Diode Voltage	V <sub>SD</sub>	I <sub>S</sub> = 1 A			1	V	
Body Diode Reverse Recovery Time	t <sub>rr</sub>			60		ns	
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>	I <sub>F</sub> = 40 A, di/dt = 100 A/μs, T <sub>J</sub> = 25 °C		75		nC	
Reverse Recovery Fall Time	t <sub>a</sub>			30			
Reverse Recovery Rise Time	t <sub>b</sub>			29		ns	

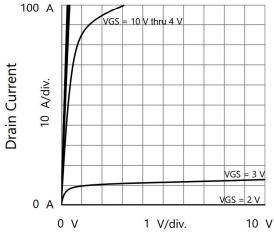
#### Notes:

- a. Pulse test; pulse width  $\leq$  300  $\mu$ s, duty cycle  $\leq$  2 %. b. Guaranteed by design, not subject to production testing.

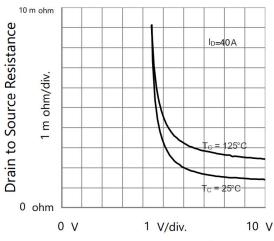
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.



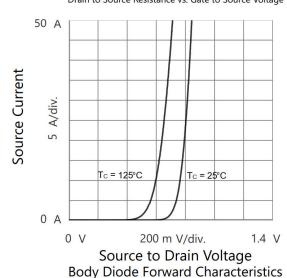
## TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

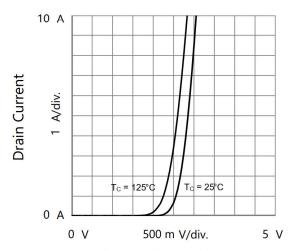


Drain to Source Voltage Output Characteristics

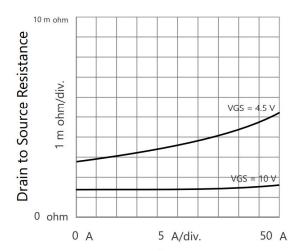


Gate to Source Voltage
Drain to Source Resistance vs. Gate to Source Voltage

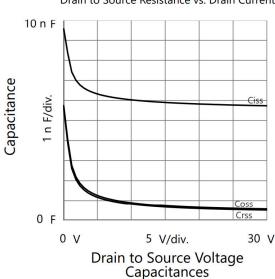




Gate to Source Voltage Transfer Characteristics



Drain Current
Drain to Source Resistance vs. Drain Current

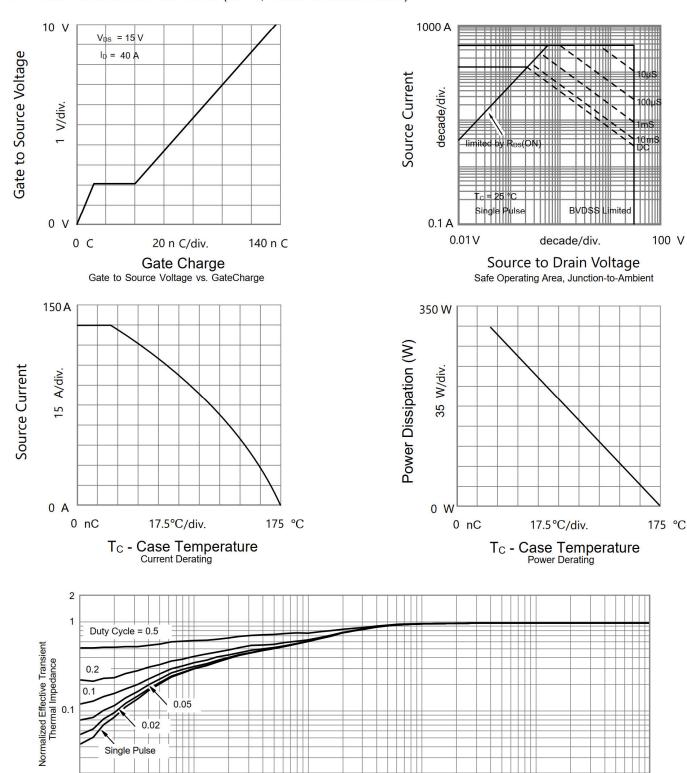




0.01 \_\_\_

10-3

### TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



Square Wave Pulse Duration (s)

Normalized Thermal Transient Impedance, Junction-to-Case

10-1

1

10-2

10





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